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Application/Control No.	Applicant(s)/Patent under Reexamination
10/807,667	CHEE ET AL.
Examiner	Art Unit
B. Clayton McCraw	3744

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Class	Subclass	Date	Examiner
62	175,305,3 14	10/22/2005	всм
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SEARCH NOT (INCLUDING SEARCH	'ES STRATEGY))
	DATE	EXMR
Consulted with Primary Examiner, William Doerrler	10/22/2005	всм
Conducted Inventor Name Search	10/22/2005	всм
Consulted with Acting Supervisory Patent Examiner, Melba Bumgarner	10/22/2005	всм
EAST Search Notes Attached	10/24/2005	всм